

Investigation of the spectra of coupled polaritons on the periodically modulated metallic layer and the narrow regions of anomalous transparency

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Abstract

The paper deals with the theoretical investigation of plane, normally incident electromagnetic wave transmission through the flat metal film whose dielectric constant has small periodical sinusoidal modulation in one dimension parallel to the projection of the electric field onto the film surface. The dependencies of the film transmittancy on the parameters of the problem (frequency, modulation depth and absorption) are examined. It is shown that the film transmittancy increases considerably when the conditions for resonance interaction of an incident electromagnetic wave with surface plasmon polaritons (SPPs) are met. It is found that for small but finite absorption there are two frequencies in the vicinity of which the transmittancy can achieve the values of the order of unity due to resonances on symmetric and antisymmetric (relative to the mean plane) SPP modes. It is shown that for each value of absorption there exists a certain optimal modulation depth, which maximizes the resonance transparency.

Keywords: plasmon polaritons, dispersion relation, resonance diffraction, photonic crystals

1 Introduction

A metal-dielectric interface is known to be able to sustain surface plasmon polaritons (SPPs) [1], i.e., collective excitations of surface electron density coupled to the electromagnetic field. Since the SPP phase and group velocities are less than the velocity of light, the SPPs cannot be excited by external electromagnetic wave falling on a perfectly flat metal surface [2, 3]. Nevertheless, when the film is periodically modulated and a spatial period of modulation coincides with the wavelength of SPP, the latter can be excited by a normal incident electromagnetic wave. This leads to the well-known Wood anomalies discovered in 1902 for the reflectance spectra of metallic gratings illuminated by p - (TM -) polarized light [4]. Later these anomalies were associated with the SPP excitation [5]. Since then both reflection [6, 7, 8, 9] and transmission [9, 10, 11, 12, 13, 14] gratings are of great interest to physicists. In reflection gratings two types of anomalies have been predicted theoretically [6, 7, 9] and later confirmed experimentally [8]: the effect of SPP excitation is responsible for the

existence of one anomaly¹, and the other one exists when the depth of the grating grooves exceeds some critical value (of order of the quarter wavelength). The latter anomaly is associated with the standing waves having the field energy highly concentrated inside the grooves. Transmission gratings exhibit an unusual property: this kind of structures can be highly transmitting at certain frequencies [10, 11]. As it was originally shown in paper [12], there are two types of transmission resonances in the transmission grating: coupled SPPs on both horizontal surfaces of the metallic grating, and cavity modes located inside the slits. The authors of paper [13] preferred to identify these resonances as horizontal and vertical SPP resonances, respectively. Recently these resonances have been confirmed experimentally [14].

Another kind of transmitting structures was proposed recently: a flat, optically thick metal film, perforated with the subwavelength hole 2D array [15, 16, 17, 18, 19]. The transmission of light through these structures (due to SPP resonance) can be much larger than that expected from the standard aperture theory [20]. Notice that this extraordinary transmission effect has potential applications [21, 22, 23] in subwavelength photolithography, near-field microscopy, wavelength-tunable filters, optical modulators, and flat-panel displays.

To obtain the high transmittancy of the metal film, instead of hole array one can use the films with spatially modulated dielectric constant [24, 25]. The transmission of the electromagnetic wave through the flat metal film, whose dielectric constant has 1D modulation of sinusoidal shape, was considered in paper [24]. It has been found that at the SPP resonance such dissipation-free films become fully transparent regardless of its thickness; however, the width of transmission resonance shrinks when the film thickness increases. Recently, an attempt of analytical treatment of optical transmission through periodically modulated metal films capable of supporting SPPs has been presented in paper [25]. However, in the above-mentioned paper the coupling between SPPs on different film boundaries has not been taken into account explicitly. Also the authors of papers [24, 25] neglected the field dissipation in the metal film and obtained the expression for film transmittancy without taking into consideration the off-resonance second spatial field harmonic.

In this paper we examine theoretically transmission of a plane normally incident electromagnetic wave through the flat metal film with dielectric constant being periodically modulated in one in-plane dimension. We analyze the transmittance in the case where the periodicity is caused by a sinusoidal shape modulation. The dependencies of the film transmittancy upon incident wave frequency, modulation depth and film thickness are investigated. It is found that the film transmittancy increases considerably when the conditions for resonance interaction between the incident electromagnetic wave and SPPs are satisfied and light absorption is small. It is shown that the dependence of the film transmittancy upon incident electromagnetic wave frequency exhibits two maxima, which correspond to the resonances on symmetric and antisymmetric SPP modes. The values of the film transmittancy in the vicinity of maxima can be much higher than that of the unmodulated film. It is shown that when the losses in the metal are taken into account, a certain optimal modulation depth (which maximizes the film resonance transparency) corresponds to each value of the losses.

¹Here it is necessary to underline that except the SPP excitation there exists another type anomaly related to the parameters (wavelength, angle of incidence) such that one of the diffracted orders intersects the boundary between propagating and evanescent waves. From the formal point of view it corresponds to the branch point in a Fourier expansion and was first indicated by Lord Rayleigh in discussion on Wood's experiments. For good metals this anomaly is close to that related to the SPP excitation. Note that for infinitely conducting media these two anomalies coincide. These two anomalies are often called as Wood anomaly (in a broad sense); it seems better to call the former Wood anomaly and the latter Rayleigh anomaly.

The paper is organized as follows. In section 2 we derive the algebraic expression for the modulated film transmittancy. In section 3 the transmission properties of the film are analyzed and the numerical results are presented. The paper is concluded with a brief summary of results and possible applications (section 4).

2 Problem statement and main equations

Consider a flat metallic film of a finite thickness d , supposing that the film/air boundaries coincide with the planes $z = 0$ and $z = d$ (see Fig.1). Besides, the dielectric constant of the film is considered to be modulated along direction x as

$$\varepsilon(x) = \varepsilon'_m(1 - i\delta + a \cos(gx)). \quad (1)$$

Here $\varepsilon_m = \varepsilon'_m(1 - i\delta)$ is the complex dielectric permittivity of an unmodulated metal ($\varepsilon'_m < 0$), δ is the loss angle tangent, a is the modulation depth, $g = 2\pi/b$ is the modulation wavenumber (b is the period of modulation).

The plane p-polarized electromagnetic wave is assumed to propagate in a positive z -axis direction. Since the solution of our problem has to be uniform along direction y , we can assign $\frac{\partial}{\partial y} \equiv 0$. Besides, we suppose that $\vec{E}, \vec{H} \sim \exp(-i\omega t)$. In this case the Maxwell equations for p-polarized electromagnetic wave can be represented in the form ($E_y = H_x = H_z = 0$):

$$\frac{\partial H_y(x, z)}{\partial z} = \frac{i\omega}{c} \varepsilon(x) E_x(x, z), \quad (2)$$

$$\frac{\partial H_y(x, z)}{\partial x} = -\frac{i\omega}{c} \varepsilon(x) E_z(x, z), \quad (3)$$

$$\frac{\partial E_z(x, z)}{\partial x} - \frac{\partial E_x(x, z)}{\partial z} = -\frac{i\omega}{c} H_y(x, z). \quad (4)$$

Since the dielectric permittivity is periodic, the solution of equations (2)–(4) can be given in the form of Fourier–Floquet series. Due to supposed smallness of the modulation, we can truncate this expansion taking into account three spatial field harmonics only. Thus, the y -component of the magnetic field can be written as

$$H_y(x, z) = H_0(z) + H_1(z) \cos(gx) + H_2(z) \cos(2gx). \quad (5)$$

Here $H_0(z)$, $H_1(z)$, $H_2(z)$ are the amplitudes of zeroth, first and second spatial harmonics of magnetic field, respectively.

Substituting the expression (5) in the Maxwell equations, and neglecting the terms of a^2 order, we obtain

$$H_0''(z) + k^2 \varepsilon_m H_0(z) - \alpha H_1''(z) = 0, \quad (6)$$

$$H_1''(z) - (g^2 - k^2 \varepsilon_m) H_1(z) - 2\alpha H_0''(z) - \alpha [H_2''(z) - 2g^2 H_2(z)] = 0, \quad (7)$$

$$H_2''(z) - (4g^2 - k^2 \varepsilon_m) H_2(z) - \alpha [H_1''(z) - 2g^2 H_1(z)] = 0. \quad (8)$$

Here $\alpha = (a/2)(1 - i\delta)^{-1}$, and the primes denote the derivatives with respect to z .

The eigenvalues of the homogeneous set of equations (6)-(8) can be found from the bicubic characteristic equation

$$(\gamma^2 - P_0^2)(\gamma^2 - P_1^2)(\gamma^2 - P_2^2) - \alpha^2 \left[(\gamma^2 - P_0^2)(\gamma^2 - 2g^2)^2 + 2\gamma^4(\gamma^2 - P_2^2) \right] = 0, \quad (9)$$

where

$$P_n^2 = n^2 g^2 - k^2 \varepsilon_m, \quad n = 0, 1, 2.$$

The roots of the characteristic equation (9) can be written to within α^2 as

$$\gamma_0^2 = P_0^2 - 2\alpha^2 \frac{P_0^4}{g^2} + O(\alpha^4), \quad \gamma_1^2 = P_1^2 - \alpha^2 \frac{[P_1^2 - 2g^2]^2}{3g^2} + 2\alpha^2 \frac{P_1^4}{g^2} + O(\alpha^4),$$

$$\gamma_2^2 = P_2^2 + \alpha^2 \frac{[P_2^2 - 2g^2]^2}{3g^2} + O(\alpha^4).$$

The general solution of equations (6)-(8) can be given in the form (since $|\alpha| \ll 1$, for our purposes it is sufficient to restrict our consideration of the solution to the linear terms in α)

$$H_0(z) = \left\{ B_0^{(s)} \sinh \gamma_0 z + B_0^{(c)} \cosh \gamma_0 z \right\} + \alpha \phi_{01} \left\{ B_1^{(s)} \sinh \gamma_1 z + B_1^{(c)} \cosh \gamma_1 z \right\}, \quad (10)$$

$$H_1(z) = 2\alpha \phi_{10} \left\{ B_0^{(s)} \sinh \gamma_0 z + B_0^{(c)} \cosh \gamma_0 z \right\} + \left\{ B_1^{(s)} \sinh \gamma_1 z + B_1^{(c)} \cosh \gamma_1 z \right\} + \alpha \phi_{12} \left\{ B_2^{(s)} \sinh \gamma_2 z + B_2^{(c)} \cosh \gamma_2 z \right\}, \quad (11)$$

$$H_2(z) = \alpha \phi_{21} \left\{ B_1^{(s)} \sinh \gamma_1 z + B_1^{(c)} \cosh \gamma_1 z \right\} + \left\{ B_2^{(s)} \sinh \gamma_2 z + B_2^{(c)} \cosh \gamma_2 z \right\}. \quad (12)$$

Here

$$\phi_{nl} = \frac{\gamma_l^2 - nlg^2}{\gamma_l^2 - P_n^2}, \quad n, l = 0, 1, 2,$$

$B_n^{(s)}$, $B_n^{(c)}$ are the arbitrary coefficients corresponding to the eigenfunctions of equations (6)-(8). The coefficients $B_n^{(s)}$, $B_n^{(c)}$ are to be obtained by matching the boundary conditions.

The fields outside the film can be found from equations (6)-(8), if we put $\varepsilon(x) = 1$ and $\alpha = 0$. Apart from this, for the first and the second spatial harmonics we have to use radiation boundary conditions. So, the spatial harmonics of magnetic field outside the film are

$$H_0^-(z) = H_i \exp[-p_0 z] + H_r \exp[p_0 z], \quad H_1^-(z) = H_1^- \exp[p_1 z], \quad (13)$$

$$H_2^-(z) = H_2^- \exp[p_2 z], \quad z \leq 0,$$

$$H_0^+(z) = H_t \exp[-p_0(z-d)], \quad H_1^+(z) = H_1^+ \exp[-p_1(z-d)], \quad (14)$$

$$H_2^+(z) = H_2^+ \exp[-p_2(z-d)], \quad z \geq d.$$

Here H_i , H_r , H_t are the amplitudes of incident, transmitted and reflected waves, correspondingly, $H_1^\pm$, $H_2^\pm$ are the amplitudes of the first and the second harmonics, $p_n = \sqrt{n^2 g^2 - k^2}$, $\text{Re}(p_n) - \text{Im}(p_n) \geq 0$,

$n = 0, 1, 2$. The tangential component of electric field can be obtained from the equation (2) and with accuracy up to the linear in α terms can be represented in the form

$$E_x = \frac{1}{ik\varepsilon_m} [H'_0(z) - \alpha H'_1(z) + \cos(gx) \{H'_1(z) - 2\alpha H'_0(z) - \alpha H'_2(z)\} + \cos(2gx) \{H'_2(z) - \alpha H'_1(z)\}]. \quad (15)$$

The continuity of the tangential components of the electric and magnetic field at boundaries $z = 0$ and $z = d$ results in the following system of linear equations

$$\hat{H}_0 X_0 + \alpha \hat{A}_{01} X_1 = G. \quad (16)$$

$$2\alpha \hat{A}_{10} X_0 + \hat{H}_1 X_1 + \alpha \hat{A}_{12} X_2 = 0, \quad (17)$$

$$\alpha \hat{A}_{21} X_1 + \hat{H}_2 X_2 = 0. \quad (18)$$

Here

$$\hat{H}_l = \begin{pmatrix} 1 & 0 & -1 & 0 \\ 0 & \eta_l & p_l & 0 \\ \cosh \gamma_l d & \sinh \gamma_l d & 0 & -1 \\ \eta_l \sinh \gamma_l d & \eta_l \cosh \gamma_l d & 0 & -p_l \end{pmatrix}, \quad \hat{A}_{nl} = \begin{pmatrix} \phi_{nl} & 0 & 0 & 0 \\ 0 & \eta_l \Phi_{nl} & 0 & 0 \\ \phi_{nl} \cosh \gamma_l d & \phi_{nl} \sinh \gamma_l d & 0 & 0 \\ \eta_l \Phi_{nl} \sinh \gamma_l d & \eta_l \Phi_{nl} \cosh \gamma_l d & 0 & 0 \end{pmatrix},$$

$$X_0 = \begin{pmatrix} B_0^{(c)} \\ B_0^{(s)} \\ H_r \\ H_t \end{pmatrix}, \quad X_1 = \begin{pmatrix} B_1^{(c)} \\ B_1^{(s)} \\ H_1^- \\ H_1^+ \end{pmatrix}, \quad X_2 = \begin{pmatrix} B_2^{(c)} \\ B_2^{(s)} \\ H_2^- \\ H_2^+ \end{pmatrix}, \quad G = \begin{pmatrix} H_i \\ p_0 H_i \\ 0 \\ 0 \end{pmatrix},$$

$$\Phi_{nl} = \phi_{nl} - 1, \quad \eta_n = -\gamma_n / \varepsilon_m$$

The solution of equations (16)–(18) for the fundamental (zeroth), the first and the second spatial harmonics can be written as

$$X_0 = [\hat{I} + 2\alpha^2 \hat{H}_0^{-1} \hat{A}_{01} \hat{F}^{-1} \hat{A}_{10}] \hat{H}_0^{-1} G, \quad (19)$$

$$X_1 = -2\alpha \hat{F}^{-1} \hat{A}_{10} \hat{H}_0^{-1} G, \quad (20)$$

$$X_2 = 2\alpha^2 \hat{H}_2^{-1} \hat{A}_{21} \hat{F}^{-1} \hat{A}_{10} \hat{H}_0^{-1} G, \quad (21)$$

where

$$\hat{F} = \hat{H}_1 - 2\alpha^2 \hat{A}_{10} \hat{H}_0^{-1} \hat{A}_{01} - \alpha^2 \hat{A}_{12} \hat{H}_2^{-1} \hat{A}_{21}, \quad (22)$$

$\hat{I}$ is the unit 4×4 matrix. The main features of electromagnetic wave transmission through the modulated film can be deduced from the analysis of expression (19). Matrices $\hat{H}_0$ and $\hat{H}_2$ are the nonsingular matrices. At the same time matrix $\hat{H}_1$ is a singular matrix. The condition $\text{Det}[\hat{H}_1] = 0$, $[p_1 \tanh \gamma_1 d - \eta_1] [p_1 - \eta_1 \tanh \gamma_1 d] = 0$ is known to be the dispersion relation for SPP (with wavenumber g and frequency ω) on the unmodulated film [26]. Thus, if the frequency of an incident wave is far enough from the SPP frequency (i.e. the value of $\text{Det}[\hat{F}]$ is far from zero), the term,

proportional to α^2 in expression (19) can be neglected and then $X_0 \approx \hat{H}_0^{-1}G$. In other words, the transmittancy of the film with modulated dielectric permittivity is approximately equal to that of the unmodulated film. If the incident wave frequency is close to that of the SPP symmetric or antisymmetric mode of the modulated film (i.e. $\text{Det}[\hat{F}] \approx 0$) then the term proportional to α^2 achieves the values of order of unity and becomes comparable with the first term. Therefore, the transmittancy of the film with modulated dielectric permittivity differs considerably from that of the unmodulated film.

3 Results

In this section we investigate the dependence of film transmittancy upon frequency, modulation depth, film thickness and losses.

The dependence of the modulated film transmittancy upon the frequency of incident wave is presented in Fig.2. For the comparison the frequency dependence of the unmodulated film transmittancy for the same values of parameters is depicted in Fig.2 by dashed lines. As evident from Fig.2, the frequency dependence of modulated film transmittancy exhibits two resonance maxima. At the same time the value of the modulated film transmittancy at frequencies close to the resonance frequencies is much higher than the value of uniform unmodulated film transmittancy. In particular, when there are no losses in the film (curve 1), the value of the modulated film transmittancy at resonances is equal to unity. In other words, the full transmission of incident electromagnetic wave through the lossless film with modulated dielectric permittivity is possible at two fixed frequencies. The reason for full transparency of the metal film with modulated dielectric permittivity lies in the following. The SPP spectrum of a finite thickness film contains two modes, the high-frequency (HF) symmetric mode and the low-frequency (LF) antisymmetric mode [26]. The SPP symmetric mode is characterized by the fact that the values of the SPP magnetic field at film boundaries $z = 0$ and $z = d$ are equal, and z -components of the electric field (along with the surface charge density) are of different signs, i.e., the HF eigenmode possesses reflective symmetry with respect to the plane $z = d/2$. At the same time the values of the SPP antisymmetric mode magnetic field at the film boundaries have opposite signs. So, the LF eigenmode possesses reflective antisymmetry with respect to the plane $z = d/2$. Nevertheless, the absolute values of the SPP electric and magnetic field amplitudes at the film boundaries $z = 0$ and $z = d$ are equal to each other both for the SPP symmetric mode and for the SPP antisymmetric one. Hence, in the case where the film modulation period is equal to the SPP wavelength (i.e. the conditions for the SPP excitation are met) the incident wave upon diffracting on the modulation excites the SPP at boundary $z = 0$. Further, following the interaction with the modulation, at boundary $z = d$ the SPP transforms into the bulk electromagnetic wave, this electromagnetic wave being radiated with the same amplitude as an incident wave (due to the above-mentioned equality between the SPP field amplitudes at both of the boundaries). Thus, the transmittancy of the lossless film with modulated dielectric permittivity is equal to unity if the absorbance in the film is absent and when the conditions for the SPP excitation are met. Fig.2 also shows that as the losses increase, the modulated film transmittancy decreases monotonically. At the same time when losses in the film are taken into account, the maximum value of transmittancy for the LF resonance exceeds that for the HF resonance.

The necessity to allow for the second spatial harmonic in the expression (5) is seen from Fig.3, which depicts the frequency dependence of the second spatial harmonic amplitude at boundary $z = 0$

in the case where the losses in the film do not exist. As seen from Fig.3, the amplitude of the second spatial harmonic at frequencies far from the SPP resonance frequencies are considerably less than the amplitude of the incident wave. At the same time the value of the second spatial harmonic amplitude in the vicinity of resonances is of the same order as the amplitude of the incident wave. The need to take into account the second spatial harmonic, when the expressions for the modulated film transmittancy and reflectance are obtained, follows from this ratio between the amplitudes of the second harmonic and the incident wave.

The influence of the modulation depth value upon the modulated film transmittancy and upon the value of resonance peak frequency is shown in Fig.4. As Fig.4 illustrates, as the modulation depth a increases, the resonance peak frequency decreases monotonically both in the case of LF resonance (curves 1',2' in Fig.4a) and in the case of HF resonance (curves 3',4' in Fig.4b). As it follows from the comparison of curves 1',2', the LF resonance peak frequency is increased, as the film thickness increases (Fig.4a). At the same time the HF resonance peak frequency is decreased, as the film thickness increases (Fig.4b). Note that at LF resonance (Fig.4a), as the modulation depth a increases, the value of the transmittance maximum T_{max} increases as well (at small values of a). However, starting from some value of the modulation depth a_{opt} ($a_{opt} \approx 0.072$ for $\omega_0 d/c = 0.5$ and $a_{opt} \approx 0.073$ for $\omega_0 d/c = 1.0$) the value of T_{max} decreases with an increase of a . At HF resonance (Fig.4b), the value of T_{max} reaches its maximum, when $a_{opt} \approx 0.076$ (for $\omega_0 d/c = 0.5$) and when $a_{opt} \approx 0.072$ (for $\omega_0 d/c = 1.0$). Thus, both for LF resonance and for HF resonance with the losses in the film being taken into account, there exists a certain value a_{opt} , which corresponds to the “optimal tuning”: when the modulation depth of the film is equal to a_{opt} , the resonance transmission of the electromagnetic wave through the modulated film is highest for the given value of losses. This phenomenon can be explained as follows: when the film modulation depth is equal to a_{opt} , the SPP excitation occurs with the highest effectiveness due to the equality of free space impedance and modulated film impedance. Besides, Fig.4a shows that the value of T_{max} at LF resonance is decreased, as the film thickness d increases. At the same time in the case of the HF resonance, as the film thickness increases, the value of T_{max} increases likewise (Fig.4b).

This phenomenon is illustrated in detail in Fig.5, which presents the dependence of transmittancy maximum value and resonance peak frequency upon the film thickness. As seen from Fig.5, with an increase of the film thickness, the value of transmittance maximum T_{max} is decreased monotonically for the LF resonance (curve 1). At the same time at the HF resonance the value of T_{max} is monotonically increased with an increase of d (curve 2) and in the limit $d \rightarrow \infty$ the values of T_{max} for two resonances coincide. With an increase in d the resonance peak frequency increases in the case of the LF resonance (curve 1') and decreases in the case of the HF resonance (curve 2').

The dependence of the optimal modulation depth upon the losses is depicted in Fig.6 in the cases of LF and HF resonances. As Fig.6 shows, at small values of losses the value of optimal modulation depth does not depend essentially upon the value of losses. However, at high values of losses and when the film thickness is small (curves 1,1',2,2') the value of a_{opt} is decreased monotonically as the value of δ increases. At the same time at large values of film thickness (curves 3,3') and at high values of the losses the optimal modulation depth is increased as the value of δ increases. Besides, as indicated in Fig.6a, with an increase of the film thickness, the value of a_{opt} for the LF resonance also increases over the whole range of losses. Nevertheless, at HF resonance (see Fig.6b) as the film thickness increases, the value of a_{opt} increases only in the case of high values of losses. However at small values of δ the value of a_{opt} for HF resonance is decreased with increasing δ . It should be noted that as it follows from the comparison of Fig.6a and Fig.6b, the value of the optimal

modulation depth for the LF resonance is less sensitive to the value of losses than the value of the optimal modulation depth for the HF resonance.

The dependence of the transmission resonance width upon the film parameters is shown in Fig.7 and Fig.8. Fig.7 shows the dependence of transmission resonance width upon the modulation depth. As the modulation depth increases (see Fig.7), the transmission resonance width for small values of a increases likewise. However, when the modulation depth exceeds a certain value, the transmission resonance width decreases with an increase of the modulation depth. It should be emphasized that the comparison between curves 1 and 2 (Fig.7a) shows that in the case of LF resonance the transmission resonance width is decreased as the film thickness increases. At the same time the comparison between curves 1' and 2' (Fig.7b) results in the fact that at HF resonance the transmission resonance width increases with increasing film thickness. The detailed dependence of resonance curve width upon the film thickness is presented in Fig.8. From Fig.8 one can see the monotonous decrease of the transmission resonance width with increasing film thickness for the LF resonance (curve 1) and also the monotonous increase of transmission resonance width with an increase in film thickness for the HF resonance (curve 2).

4 Conclusion

In conclusion, we calculated the transmittance spectra of flat metallic film, whose dielectric constant is periodically modulated in one dimension parallel to the projection of the electric field onto the film surface. The transmittancy spectra has been calculated for the normally incident electromagnetic wave with the wavelength close to the period of modulation. It is found that transmittancy spectra of modulated film exhibits two maxima, the transmittancy of modulated film in the vicinity of maxima being much higher than that of unmodulated film. It is shown that this abnormally high transmittancy arises due to the transformation of incident electromagnetic wave into the symmetric or antisymmetric SPP mode on one boundary and the subsequent transformation of the above-mentioned symmetric or antisymmetric SPP mode into bulk electromagnetic wave on the other boundary. This property enables one to make such film transparent for the incident radiation and it is shown that for small but finite absorption the transmittancy can achieve the values of the order of unity. It is found that when losses in the film are taken into account there exists an “optimal tuning” of the film, i.e. the ratio between the losses and the modulation depth of the film, which corresponds to the highest resonance transmittancy.

The phenomenon of abnormally high resonance transmittancy of the film at certain frequencies can be used in different devices (like optical filters) which have to select assigned frequency. Moreover, this phenomenon can be widely used in photo-lithography, near-field microscopy and photonics.

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References

- [1] R. H. Ritchie, “Plasma Losses by Fast Electrons in Thin Films,” *Phys. Rev.* **106**, pp. 874–881, 1957.
- [2] A. A. Maradudin, *Surface Polaritons. Electromagnetic Waves at Surfaces and Interfaces*, ed V. M. Agranovich and D. L. Mills, Amsterdam, North-Holland, 1982.
- [3] H. R  ther, *Surface Plasmons on Smooth and Rough Surfaces and on Gratings*, Springer-Verlag, Berlin, 1988.
- [4] R. W. Wood, “Anomalous diffraction gratings,” *Phys. Rev.* **48**, pp. 928–936, 1935.
- [5] U. Fano, “The theory of anomalous diffraction gratings and of quasi-stationary waves on metallic surfaces (Sommerfeld’s waves),” *J. Opt. Soc. Am.* **31**, pp. 213–222, 1941.
- [6] A. Hessel and A. A. Oliner, “A new theory of Wood’s anomalies on optical gratings,” *Appl. Opt.* **4**, pp. 1275–1297, 1965.
- [7] R. A. Watts, T. W. Preist, and J. R. Sambles, “Sharp Surface-Plasmon Resonances on Deep Diffraction Gratings,” *Phys. Rev. Lett.* **79**, pp. 3978–3981, 1997.
- [8] T. L  pez-R  os, D. Mendoza, F. J. Garc  a-Vidal, J. S  nchez-Dehesa, and B. Pannetier, “Surface Shape Resonances in Lamellar Metallic Gratings,” *Phys. Rev. Lett.* **81**, pp. 665–668, 1998.
- [9] F. J. Garc  a-Vidal and L. Mart  n-Moreno, “Transmission and focusing of light in one-dimensional periodically nanostructured metals,” *Phys. Rev. B* **66**, 155412, 2002.
- [10] U. Schr  ter and D. Heitmann, “Surface-plasmon-enhanced transmission through metallic gratings,” *Phys. Rev. B* **58**, pp. 15419–15421, 1998.
- [11] M. M. J. Treacy, “Dynamical diffraction in metallic optical gratings,” *Appl. Phys. Lett.* **75**, pp. 606–608, 1999.
- [12] J. A. Porto, F. J. Garc  a-Vidal, and J. B. Pendry, “Transmission Resonances on Metallic Gratings with Very Narrow Slits,” *Phys. Rev. Lett.* **83**, pp. 2845–2848, 1999.
- [13] S. Collin, F. Pardo, R. Teissier, and J. L. Pelouard, “Strong discontinuities in the complex photonic band structure of transmission metallic gratings,” *Phys. Rev. B* **63**, 033107, 2001.
- [14] H. E. Went, A. P. Hibbins, J. R. Sambles, C. R. Lawrence, and A. P. Crick, “Selective transmission through very deep zero-order metallic gratings at microwave frequencies,” *Appl. Phys. Lett.* **77**, pp. 2789–2791, 2000.
- [15] T. W. Ebbesen, H. J. Lezec, H. F. Ghaemi, T. Thio, and P. A. Wolff, “Extraordinary optical transmission through sub-wavelength hole array,” *Nature* **391**, pp. 667–669, 1998.
- [16] H. F. Ghaemi, T. Thio, D. E. Grupp, T. W. Ebbesen, and H. J. Lezec, “Surface plasmons enhance optical transmission through subwavelength holes,” *Phys. Rev. B* **58**, pp. 6779–6782, 1998.

- [17] T. J. Kim, T. Thio, T. W. Ebbesen, D. E. Grupp, and H. J. Lezec, “Control of Optical Transmission Through Metals Perforated with Subwavelength Hole Arrays,” *Opt. Lett.* **24**, pp. 256–258, 1999.
- [18] A. Krishnan, T. Thio, T. J. Kim, H. J. Lezec, T. W. Ebbesen, P. A. Wolff, J. B. Pendry, L. Martín-Moreno, and F. J. García-Vidal, “Evanescently coupled resonance in surface plasmon enhanced transmission,” *Opt. Commun.* **200**, pp. 1–7, 2001.
- [19] S. C. Hohng, Y. C. Yoon, D. S. Kim, V. Malyarchuk, R. Müller, Ch. Lienau, J. W. Park, K. H. Yoo, J. Kim, H. Y. Ryu, Q. H. Park, “Light emission from the shadows: Surface plasmon nano-optics at near and far fields,” *Appl. Phys. Lett.* **81**, pp. 3239–3241, 2002.
- [20] H. A. Bethe, “Theory of Diffraction by Small Holes,” *Phys. Rev.* **66**, pp. 163–182, 1944.
- [21] J. R. Sambles, “More than transparent,” *Nature* **391**, pp. 641–642, 1998.
- [22] S. C. Kitson, W. L. Barnes, and J. R. Sambles, “Full Photonic Band Gap for Surface Modes in the Visible,” *Phys. Rev. Lett.* **77**, pp. 2670–2673, 1996.
- [23] T. Thio, H. J. Lezec and T. W. Ebbesen, “Strongly enhanced optical transmission through subwavelength holes in metal films,” *Physica B* **279**, pp. 90–93, 2000.
- [24] V. A. Shubin, A. K. Sarychev, J. P. Clerc, and V. M. Shalaev, “Local electric and magnetic fields in semicontinuous metal films: Beyond the quasistatic approximation,” *Phys. Rev. B* **62**, pp. 11230–11244, 2000.
- [25] S. A. Darmanyan, A. V. Zayats, “Light tunneling via resonant surface plasmon polariton states and the enhanced transmission of periodically nanostructured metal films: An analytical study” *Phys. Rev. B.* **67**, 035424, 2003.
- [26] R. E. Camley, D. L. Mills, “Collective excitations of semi-infinite superlattice structures: Surface plasmons, bulk plasmons, and the electron-energy-loss spectrum,” *Phys. Rev. B* **29**, pp. 1695–1706, 1984.

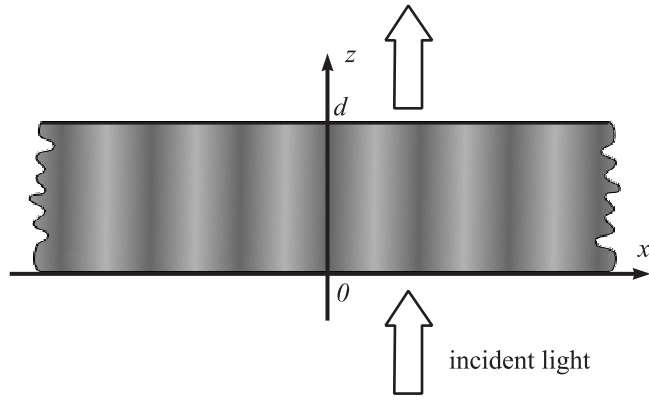


Figure 1: Geometry of the problem: a metallic film of width d with a modulated along x -direction dielectric permittivity.

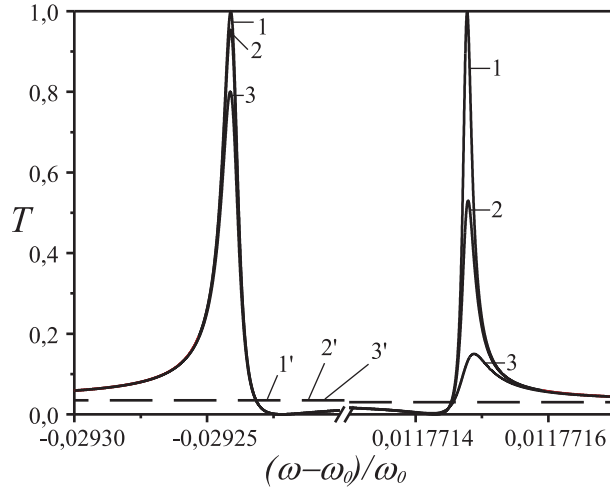


Figure 2: A frequency dependence of modulated film transmittancy (solid curves 1–3) and uniform film transmittancy (dashed curves 1'–3') for parameters $\varepsilon'_m = -25.0$, $\omega_0 d/c = 0.3$, $a = 0.02$ and for three values of losses in the film: $\delta = 0$ (curves 1,1'), $\delta = 1.0 \times 10^{-6}$ (curves 2,2') and $\delta = 5.0 \times 10^{-6}$ (curves 3,3'). The y-axis gives the film transmittancy $T = |H_t|^2/|H_i|^2$ and x-axis gives the dimensionless frequency $(\omega - \omega_0)/\omega_0$ ($\omega_0 = qc(\varepsilon_m + 1)^{1/2}(\varepsilon_m)^{-1/2}$ is the resonance frequency of SPP at the boundary between semi-infinite metal and semi-infinite vacuum). Notice, that in the scale of Fig.2 the difference between curves 1',2',3' is indistinguishable.

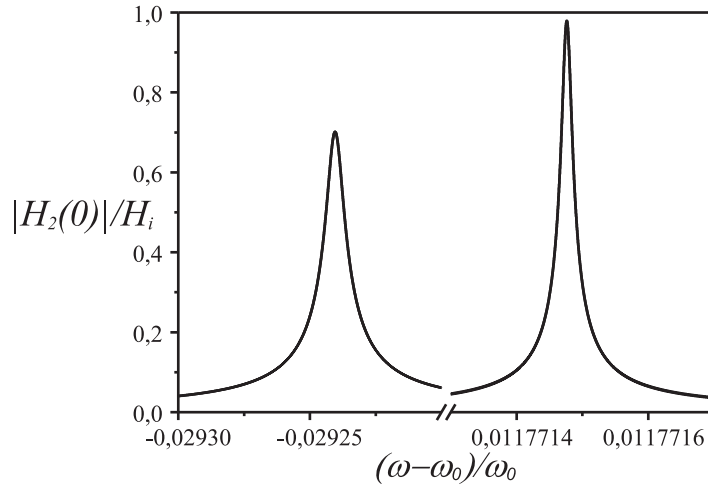


Figure 3: A frequency dependence of a magnetic field spatial harmonic amplitude $H_2(0)$ in the case where $\varepsilon'_m = -25.0$, $\omega_0 d/c = 0.3$, $a = 0.02$, $\delta = 0$. The y-axis gives the dimensionless amplitude of second harmonic $H_2(0)/H_i$ and x-axis gives the dimensionless frequency $(\omega - \omega_0)/\omega_0$.

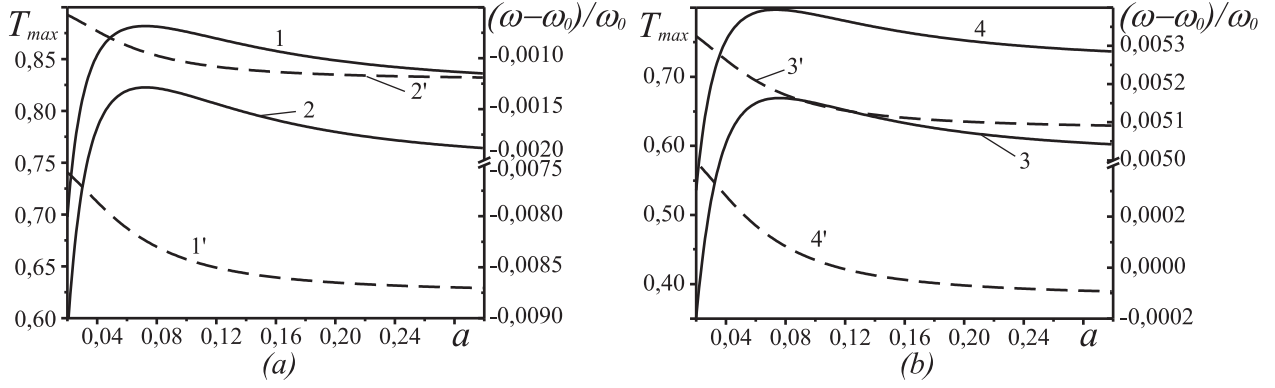


Figure 4: A dependence of a transmittance maximum value T_{max} (solid curves 1–4) and a resonance peak frequency (dashed curves 1'–4') upon a modulation depth for the LF resonance (curves 1,2,1',2' in Fig.4a) and for a HF one (curves 3,4,3',4' in Fig.4b) for parameters $\varepsilon'_m = -25.0$, $\delta = 5.0 \times 10^{-6}$ and for two film thickness values d : $\omega_0 d/c = 0.5$ (curves 1,3,1',3') and $\omega_0 d/c = 1.0$ (curves 2,4,2',4'). The x-axis gives the modulation depth a while the left-hand side y-axis gives the maximum transmittancy at resonance T_{max} and right-hand side y-axis gives the dimensionless frequency of resonance peak $(\omega - \omega_0)/\omega_0$.

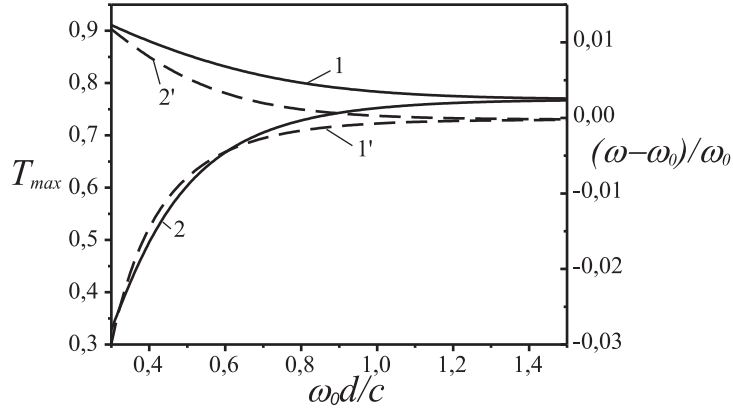


Figure 5: A dependence of a transmittance maximum value T_{max} (solid curves 1,2) and a resonance peak frequency (dashed curves 1',2') upon film thickness for the LF resonance (curves 1,1') and for a HF one (curves 2,2') for parameters $\varepsilon'_m = -25.0$, $\delta = 5.0 \times 10^{-6}$, $a = 0.04$. The x-axis gives the dimensionless film thickness $\omega_0 d/c$, the left-hand side y-axis gives the value of transmittance maximum T_{max} and the right-hand side y-axis gives the dimensionless frequency of resonance peak $(\omega - \omega_0)/\omega_0$.

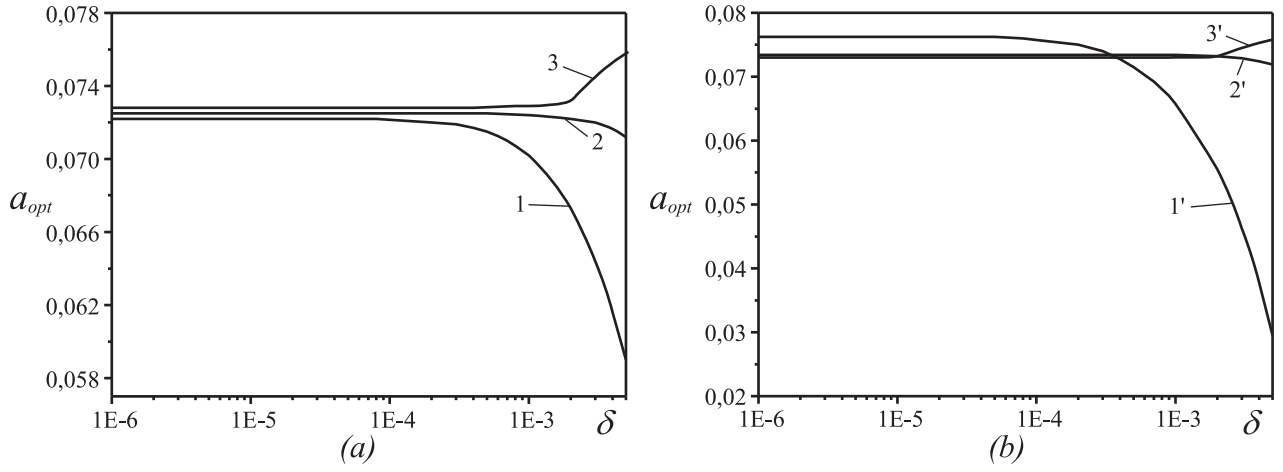


Figure 6: A dependence of optimal modulation depth upon a value of losses for a LF resonance (Fig.6a) and for a HF resonance (Fig.6b) in the case where $\varepsilon'_m = -25.0$ and for three values of film thickness d : $\omega_0 d/c = 0.5$ (curves 1,1'), $\omega_0 d/c = 1.0$ (curves 2,2'), $\omega_0 d/c = 1.5$ (curves 3,3'). The y-axis gives the optimal modulation depth a_{opt} while x-axis gives the losses in the logarithmic scale.

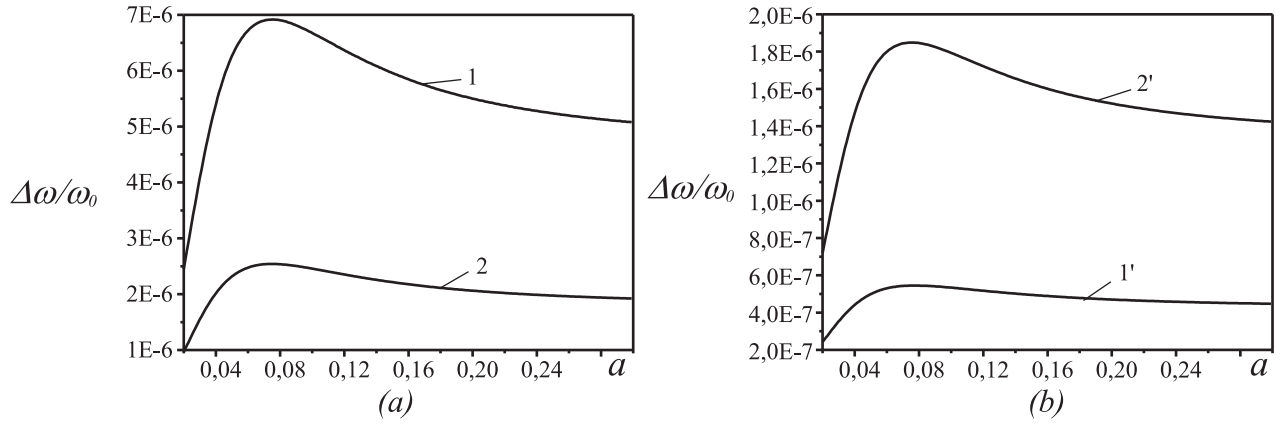


Figure 7: A dependence of the transmission resonance width upon the modulation depth for a LF resonance (Fig.7a) and for a HF one (Fig.7b) in the case where $\varepsilon'_m = -25.0$, $\delta = 5.0 \times 10^{-6}$ and for two values of film thickness d : $\omega_0 d/c = 0.5$ (curves 1,1'), $\omega_0 d/c = 1.0$ (curves 2,2'). The y-axis gives the dimensionless transmission resonance width $\Delta\omega/\omega_0$ ($\Delta\omega$ is the transmission resonance width at the level of half-value of transmittance maximum) and the x-axis gives the modulation depth a .

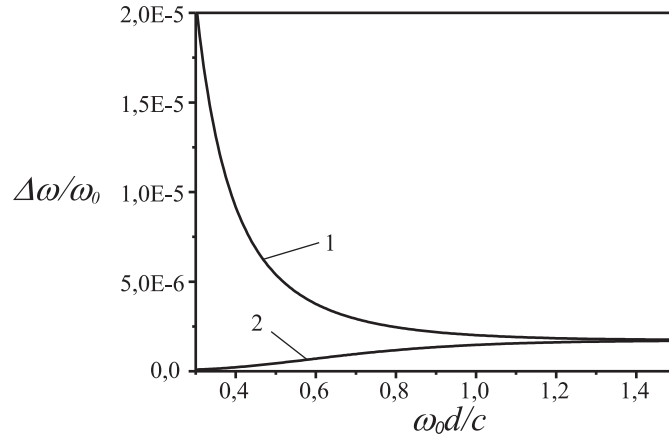


Figure 8: A dependence of transmission resonance width upon film thickness for a LF (curve 1) and HF (curve 2) resonances in the case where $\varepsilon'_m = -25.0$, $\delta = 5.0 \times 10^{-6}$, $a = 0.04$. The y-axis gives the dimensionless transmission resonance width $\Delta\omega/\omega_0$ and the x-axis gives the dimensionless film thickness $\omega_0 d/c$.